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# FDMS86255

## N-Channel Shielded Gate PowerTrench<sup>®</sup> MOSFET

150 V, 45 A, 12.4 mΩ

### Features

- Shielded Gate MOSFET Technology
- Max  $r_{DS(on)}$  = 12.4 mΩ at  $V_{GS} = 10\text{ V}$ ,  $I_D = 10\text{ A}$
- Max  $r_{DS(on)}$  = 15.5 mΩ at  $V_{GS} = 6\text{ V}$ ,  $I_D = 8\text{ A}$
- Advanced Package and Silicon combination for low  $r_{DS(on)}$  and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

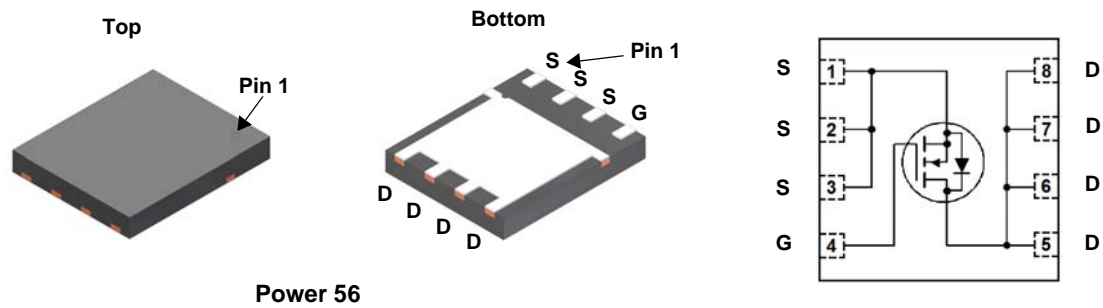


### General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

### Applications

- OringFET / Load Switching
- Synchronous rectification
- DC-DC Conversion



### MOSFET Maximum Ratings $T_A = 25\text{ °C}$ unless otherwise noted

Symbol	Parameter	Rated	Units
$V_{DS}$	Drain to Source Voltage	150	V
$V_{GS}$	Gate to Source Voltage	±20	V
$I_D$	Drain Current -Continuous $T_C = 25\text{ °C}$	45	A
	-Continuous $T_A = 25\text{ °C}$ (Note 1a)	10	
	-Pulsed (Note 4)	100	
$E_{AS}$	Single Pulse Avalanche Energy (Note 3)	541	mJ
$P_D$	Power Dissipation $T_C = 25\text{ °C}$	113	W
	Power Dissipation $T_A = 25\text{ °C}$ (Note 1a)	2.7	
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	°C

### Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	45	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS86255	FDMS86255	Power 56	13 "	12 mm	3000 units

## Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250\ \mu\text{A}, V_{GS} = 0\ \text{V}$	150			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\ \mu\text{A}$ , referenced to $25^\circ\text{C}$		109		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 120\ \text{V}, V_{GS} = 0\ \text{V}$			1	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 20\ \text{V}, V_{DS} = 0\ \text{V}$			$\pm 100$	nA

### On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\ \mu\text{A}$	2.0	3.0	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\ \mu\text{A}$ , referenced to $25^\circ\text{C}$		-11		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 10\ \text{V}, I_D = 10\ \text{A}$		9.5	12.4	m $\Omega$
		$V_{GS} = 6\ \text{V}, I_D = 8\ \text{A}$		11.5	15.5	
		$V_{GS} = 10\ \text{V}, I_D = 10\ \text{A}, T_J = 125^\circ\text{C}$		19	25	
$g_{FS}$	Forward Transconductance	$V_{DS} = 5\ \text{V}, I_D = 10\ \text{A}$		35		S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 75\ \text{V}, V_{GS} = 0\ \text{V}, f = 1\ \text{MHz}$		3200	4480	pF
$C_{oss}$	Output Capacitance			291	410	pF
$C_{rss}$	Reverse Transfer Capacitance			11	20	pF
$R_g$	Gate Resistance		0.1	0.7	2.1	$\Omega$

### Switching Characteristics

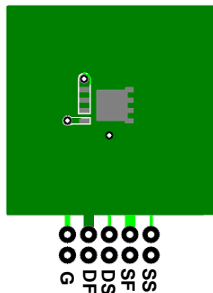
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 75\ \text{V}, I_D = 10\ \text{A}, V_{GS} = 10\ \text{V}, R_{GEN} = 6\ \Omega$		21	34	ns	
$t_r$	Rise Time			4.5	10	ns	
$t_{d(off)}$	Turn-Off Delay Time			28	45	ns	
$t_f$	Fall Time			6.2	12	ns	
$Q_g$	Total Gate Charge		$V_{GS} = 0\ \text{V to } 10\ \text{V}$		45	63	nC
$Q_g$	Total Gate Charge		$V_{GS} = 0\ \text{V to } 6\ \text{V}$		29	41	nC
$Q_{gs}$	Gate to Source Charge	$V_{DD} = 75\ \text{V}, I_D = 10\ \text{A}$		14		nC	
$Q_{gd}$	Gate to Drain "Miller" Charge			8.8		nC	

### Drain-Source Diode Characteristics

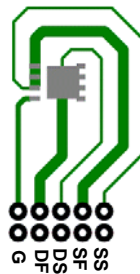
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\ \text{V}, I_S = 1.9\ \text{A}$ (Note 2)		0.7	1.2	V
		$V_{GS} = 0\ \text{V}, I_S = 10\ \text{A}$ (Note 2)		0.8	1.3	
$t_{rr}$	Reverse Recovery Time	$I_F = 10\ \text{A}, di/dt = 100\ \text{A}/\mu\text{s}$		87	139	ns
$Q_{rr}$	Reverse Recovery Charge			165	264	nC

#### Notes:

- $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.  $45^\circ\text{C}/\text{W}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b.  $115^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300  $\mu\text{s}$ , Duty cycle < 2.0%.

- $E_{AS}$  of 541 mJ is based on starting  $T_J = 25^\circ\text{C}$ ,  $L = 3\ \text{mH}$ ,  $I_{AS} = 19\ \text{A}$ ,  $V_{DD} = 150\ \text{V}$ ,  $V_{GS} = 10\ \text{V}$ . 100% tested at  $L = 0.1\ \text{mH}$ ,  $I_{AS} = 60\ \text{A}$ .

- Pulse Id refers to Figure.11 Forward Bias Safe Operation Area.

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

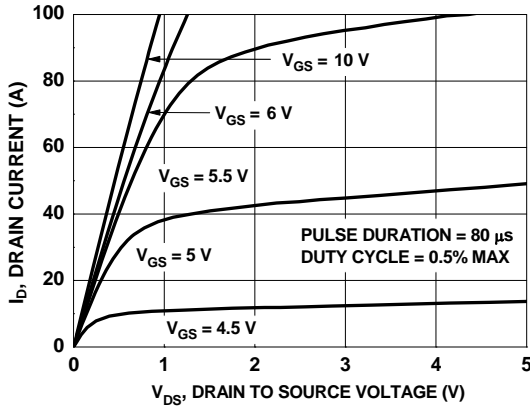


Figure 1. On-Region Characteristics

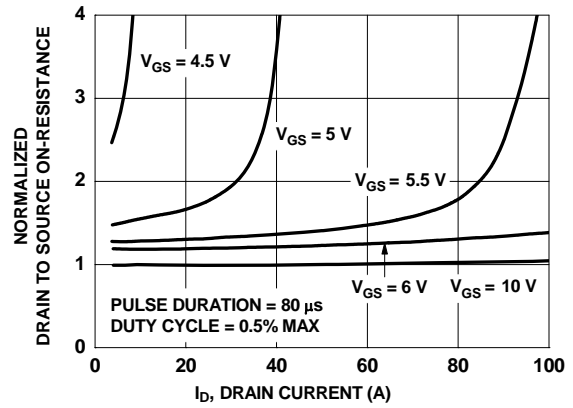


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

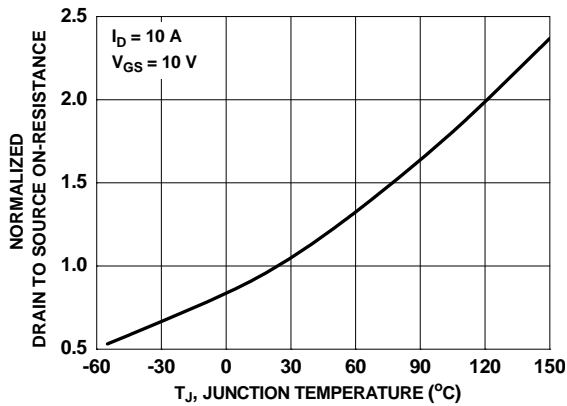


Figure 3. Normalized On-Resistance vs Junction Temperature

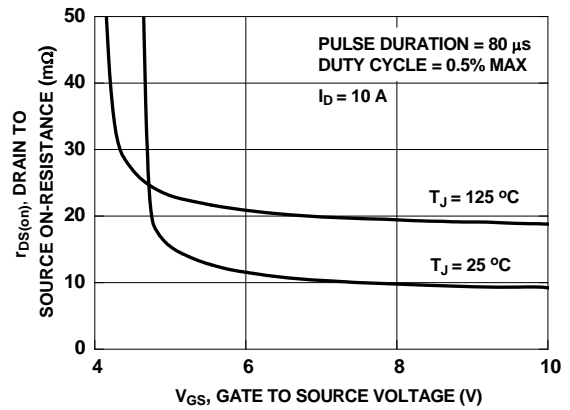


Figure 4. On-Resistance vs Gate to Source Voltage

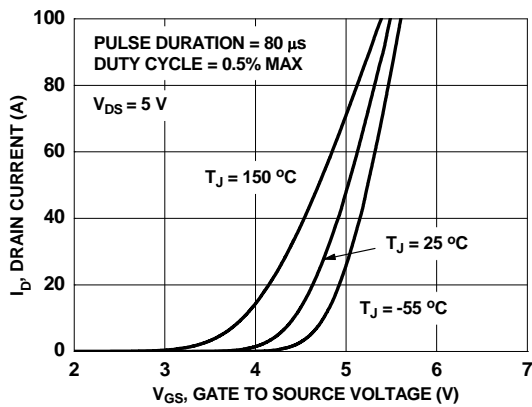


Figure 5. Transfer Characteristics

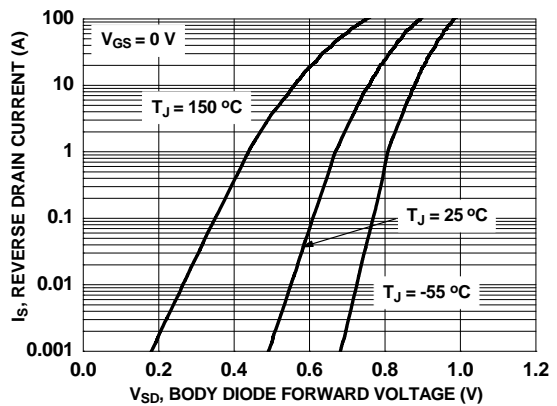
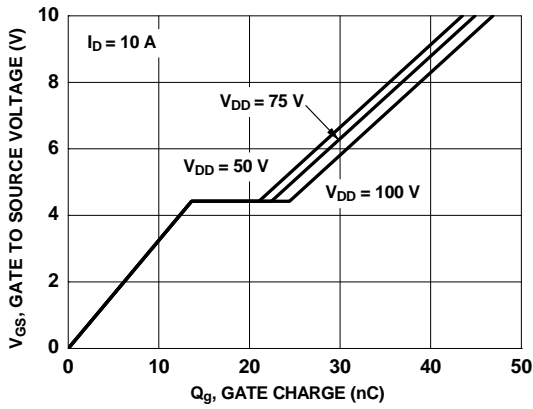
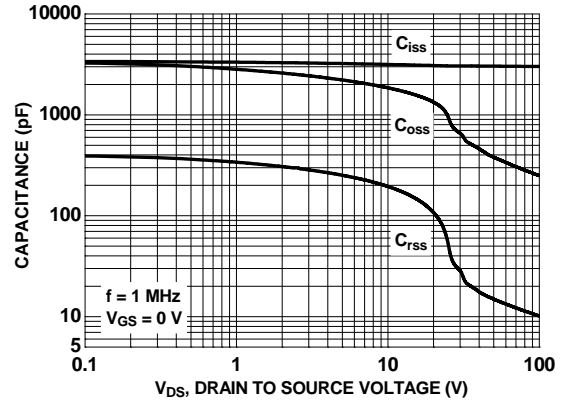


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

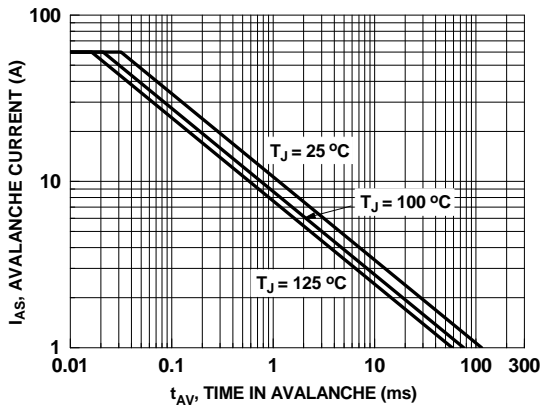
**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



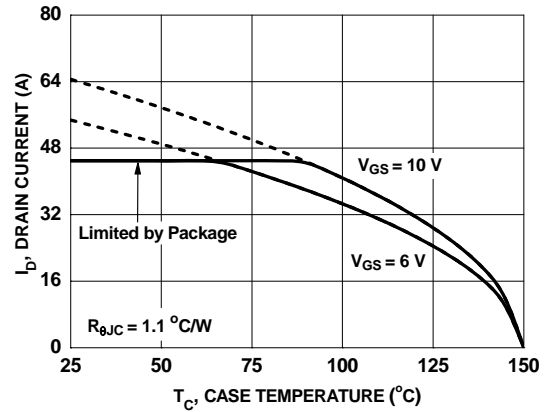
**Figure 7. Gate Charge Characteristics**



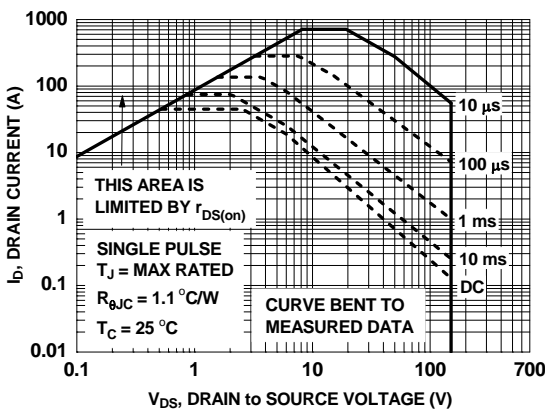
**Figure 8. Capacitance vs Drain to Source Voltage**



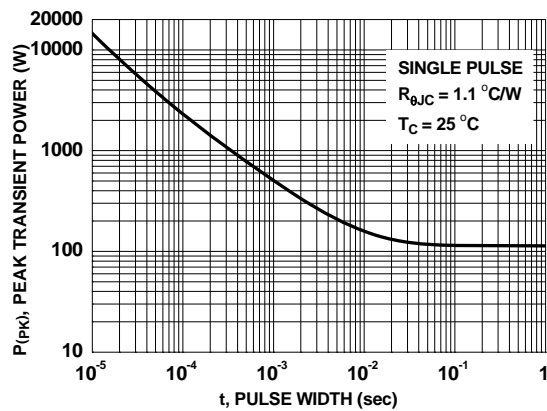
**Figure 9. Unclamped Inductive Switching Capability**



**Figure 10. Maximum Continuous Drain Current vs Case Temperature**

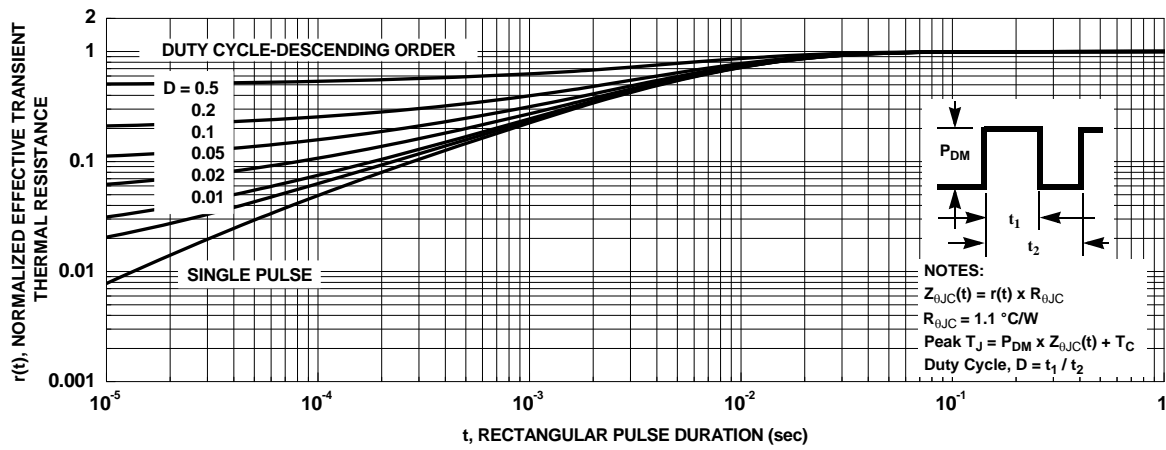


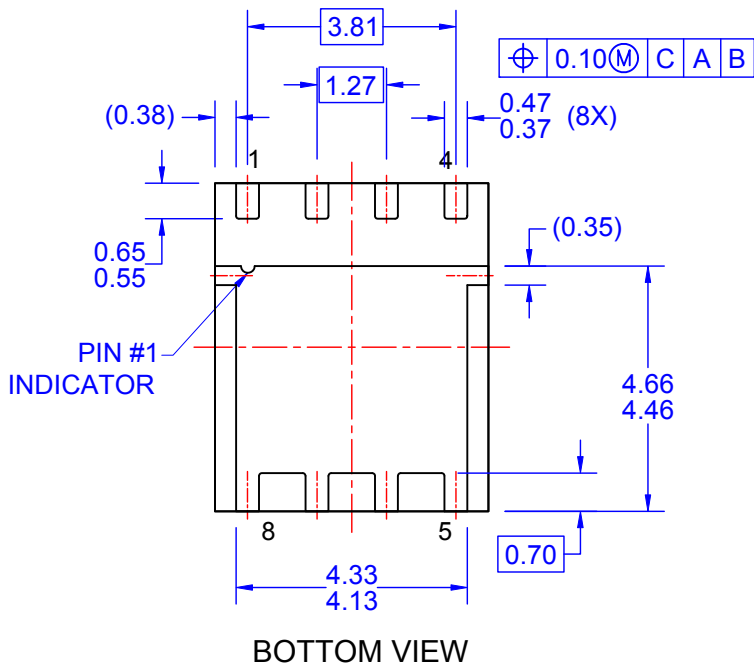
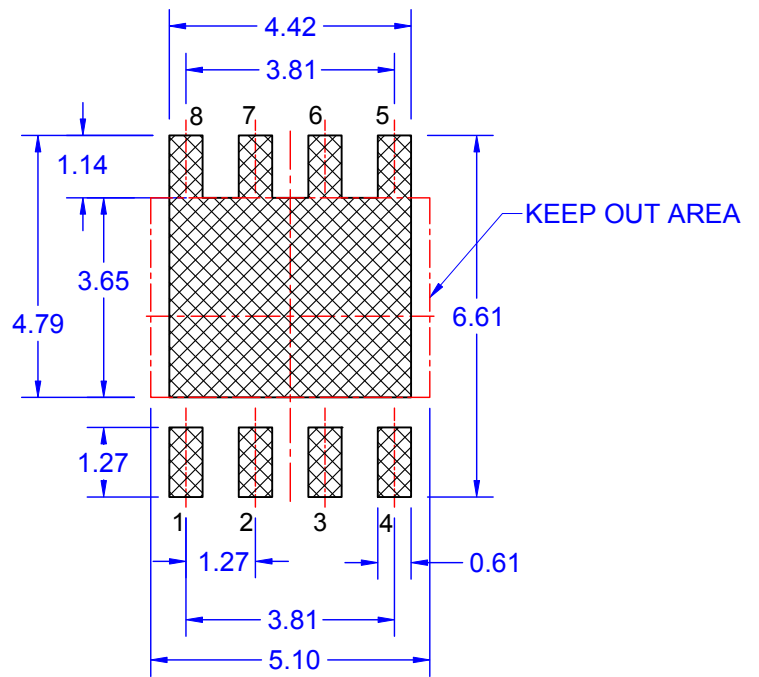
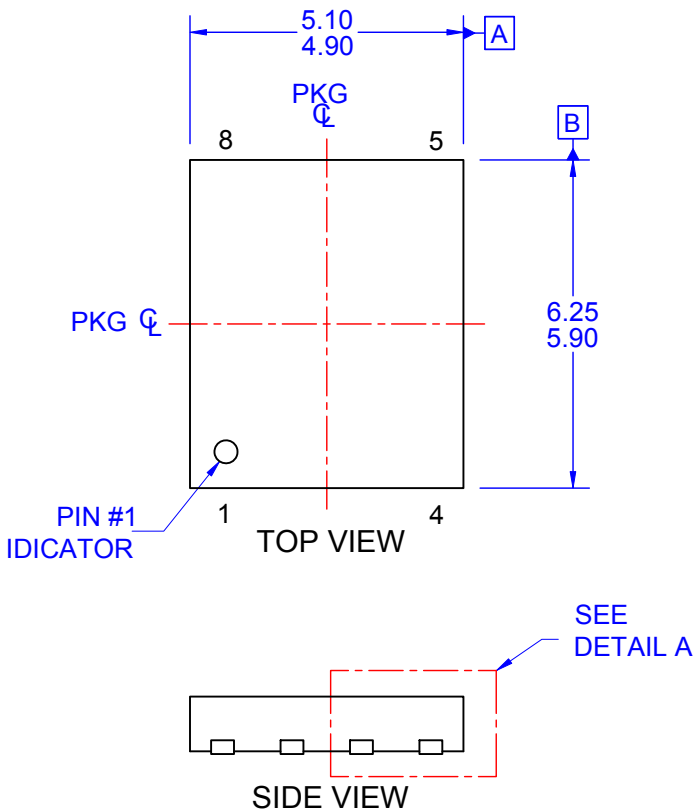
**Figure 11. Forward Bias Safe Operating Area**



**Figure 12. Single Pulse Maximum Power Dissipation**

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted





- NOTES: UNLESS OTHERWISE SPECIFIED
- A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. AA,
  - B) ALL DIMENSIONS ARE IN MILLIMETERS.
  - C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
  - D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
  - E) IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.
  - F) DRAWING FILE NAME: PQFN08JREV3.



**DETAIL A**  
SCALE: 2:1



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